

flow PHASE 0 600V/ 100A

V23990-P563-F10-01-14

Maximum Ratings / Höchstzulässige Werte

Parameter	Condition	Symbol	Datasheet values max.	Unit
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Transistor Inverter
Transistor Wechselrichter

Collector-emitter break down voltage Kollektor-Emitter-Sperrspannung		V_{CE}	600	V
DC collector current Kollektor-Dauergleichstrom	$T_J=175^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	I_C	80 104	A
Repetitive peak collector current Periodischer Kollektorspitzenstrom	tp limited by T_J max	I_{cpuls}	300	A
Power dissipation per IGBT Verlustleistung pro IGBT	$T_J=175^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	P_{tot}	124 187	W
Gate-emitter peak voltage Gate-Emitter-Spitzenspannung		V_{GE}	± 20	V
SC withstand time* Kurzschlußverhalten*	$T_J \leq 150^{\circ}\text{C}$ $V_{GE}=15\text{V}$ $V_{CC}=360\text{V}$	t_{SC}	5	us

Diode Inverter
Diode Wechselrichter

DC forward current Dauergleichstrom	$T_J=175^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	I_F	63 65, limited by bondwires	A
Repetitive peak forward current Periodischer Spitzenstrom	tp limited by T_J max	I_{FRM}	300	A
Power dissipation per Diode Verlustleistung pro Diode	$T_J=175^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	P_{tot}	85 128	W

Thermal properties
Thermische Eigenschaften

max. Chip temperature max. Chiptemperatur		T_{jmax}	175	$^{\circ}\text{C}$
Storage temperature Lagertemperatur		T_{stg}	-40...+125	$^{\circ}\text{C}$
Operation temperature Betriebstemperatur		T_{op}	-40...+125	$^{\circ}\text{C}$

Insulation properties
Modulisation

Insulation voltage Isolationsspannung	$t=1\text{min}$	V_{is}	4000	Vdc
Creepage distance Kriechstrecke			min 12,7	mm
Clearance Luftstrecke			min 12,7	mm

Additional notes and remarks:

* Allowed number of short circuits must be less than 1000 times, and time duration between short circuits should be more than 1 second!

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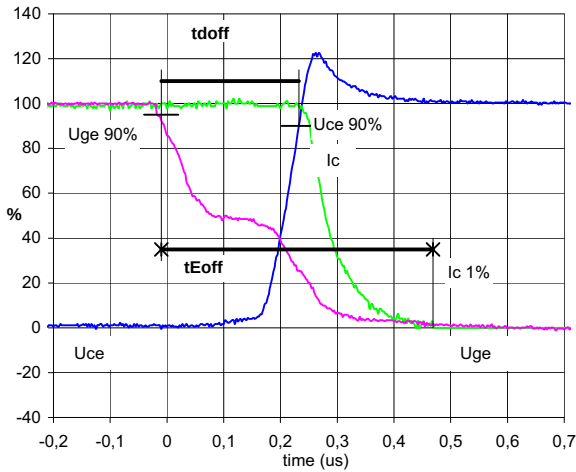
Characteristic values/ Charakteristische Werte

Description	Symbol	Conditions				Datasheet values				Unit
		T(C°)	Other conditions (Rgon-Rgoff)	VGE(V) VGS(V)	VCE(V) VDS(V)	IC(A) IF(A) Id(A)	Min	Typ	Max	
Transistor Inverter										
Transistor Wechselrichter										
Gate emitter threshold voltage	V _{GE(th)}	T _J =25°C T _J =125°C	VCE=VGE			0,0016	4	5,8	8	
Gate-Schwellenspannung										
Collector-emitter saturation voltage	V _{CE(sat)}	T _J =25°C T _J =125°C		15		100	1,3	1,48 1,65	2,1	V
Kollektor-Emitter Sättigungsspannung										
Collector-emitter cut-off	I _{CES}	T _J =25°C T _J =125°C		0	600				0,66	mA
Kollektor-Emitter Reststrom										
Gate-emitter leakage current	I _{GES}	T _J =25°C T _J =125°C		20	0				700	nA
Gate-Emitter Reststrom										
Integrated Gate resistor	R _{gint}							2		Ohm
Integrierter Gate Widerstand										
Turn-on delay time	t _{d(on)}	T _J =25°C T _J =125°C	Rgoff=4 Ω Rgon=4 Ω							ns
Einschaltverzögerungszeit				±15	300	100		71		
Rise time	t _r	T _J =25°C T _J =125°C	Rgoff=4 Ω Rgon=4 Ω	±15	300	100		26		ns
Anstiegszeit										
Turn-off delay time	t _{d(off)}	T _J =25°C T _J =125°C	Rgoff=4 Ω Rgon=4 Ω	±15	300	100				ns
Abschaltverzögerungszeit				±15	300	100		248		
Fall time	t _f	T _J =25°C T _J =125°C	Rgoff=4 Ω Rgon=4 Ω	±15	300	100		71		ns
Fallzeit										
Turn-on energy loss per pulse	E _{on}	T _J =25°C T _J =125°C	Rgoff=4 Ω Rgon=4 Ω	±15	300	100		1,04		mWs
Einschaltverlustenergie pro Puls										
Turn-off energy loss per pulse	E _{off}	T _J =25°C T _J =125°C	Rgoff=4 Ω Rgon=4 Ω	±15	300	100		3		mWs
Abschaltverlustenergie pro Puls										
Input capacitance	C _{ies}	T _J =25°C T _J =125°C	f=1MHz	0	25			6,16		nF
Eingangskapazität										
Output capacitance	C _{oss}	T _J =25°C T _J =125°C	f=1MHz	0	25			0,384		nF
Ausgangskapazität										
Reverse transfer capacitance	C _{rss}	T _J =25°C T _J =125°C	f=1MHz	0	25			0,183		nF
Rückwirkungskapazität										
Gate charge	Q _{Gate}	T _J =25°C T _J =125°C	Rgoff=4 Ω Rgon=4 Ω	±15	300	100		838,41		nC
Gate Ladung										
Thermal resistance chip to heatsink per chip	R _{thJH}		Thermal foil thickness=76um					0,77		K/W
Wärmewiderstand Chip-Kühlkörper pro Chip										
Thermal resistance chip to case per chip	R _{thJC}		Wärmeleitfolie Dicke=76um Kunze Folien KU-ALF5					0,51		K/W
Wärmewiderstand Chip-Gehäuse pro Chip										
Coupled thermal resistance inverter diode-transistor	R _{thJH}		Thermal foil thickness=76um					0,05		K/W
Gekoppelte Wärmewiderstand Wechselrichter Diode-Transistor										
Coupled thermal resistance inverter transistor-transistor	R _{thJH}		Wärmeleitfolie Dicke=76um Kunze Folien KU-ALF5					0,03		K/W
Gekoppelte Wärmewiderstand Wechselrichter Transistor-Transistor										
Diode Inverter										
Diode Wechselrichter										
Diode forward voltage	V _F	T _J =25°C T _J =125°C				100	1	1,63 1,64	2,55	V
Durchlaßspannung										
Peak reverse recovery current	I _{RM}	T _J =25°C T _J =125°C	Rgon=4 ohm di0/dt = 4894 A/us	-15	300	100		126,8		A
Rückstromspitze										
Reverse recovery time	t _{rr}	T _J =25°C T _J =125°C	Rgon=4 ohm di0/dt = 4894 A/us	-15	300	100		141		ns
Sperrverzögerungszeit										
Reverse recovered charge	Q _{rr}	T _J =25°C T _J =125°C	Rgon=4 ohm di0/dt = 4894 A/us	-15	300	100		7,47		uC
Sperrverzögerungsladung										
Reverse recovered energy	E _{rec}	T _J =25°C T _J =125°C	Rgon=4 ohm di0/dt = 4894 A/us	-15	300	100		1,85		mWs
Sperrverzögerungsenergie										
Thermal resistance chip to heatsink per chip	R _{thJH}		Thermal foil thickness=76um					1,12		K/W
Wärmewiderstand Chip-Kühlkörper pro Chip										
Thermal resistance chip to case per chip	R _{thJC}		Wärmeleitfolie Dicke=76um Kunze Folien KU-ALF5					0,74		K/W
Wärmewiderstand Chip-Gehäuse pro Chip										
Coupled thermal resistance inverter transistor-diode	R _{thJH}		Thermal foil thickness=76um					0,05		K/W
Gekoppelte Wärmewiderstand Wechselrichter Transistor-Diode										
Coupled thermal resistance inverter diode-diode	R _{thJH}		Wärmeleitfolie Dicke=76um Kunze Folien KU-ALF5					0,02		K/W
Gekoppelte Wärmewiderstand Wechselrichter Diode-Diode										

Switching definitions

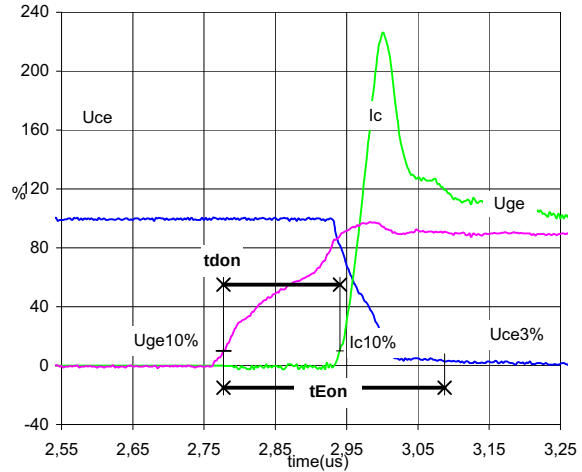
General conditions: $T_j = 125\text{ }^{\circ}\text{C}$
 $R_{gon} = 4\text{ ohms}$ $R_{goff} = 4,0\text{ ohms}$

Figure 1. Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
(t_{Eoff} = integrating time for E_{off})
Output inverter IGBT



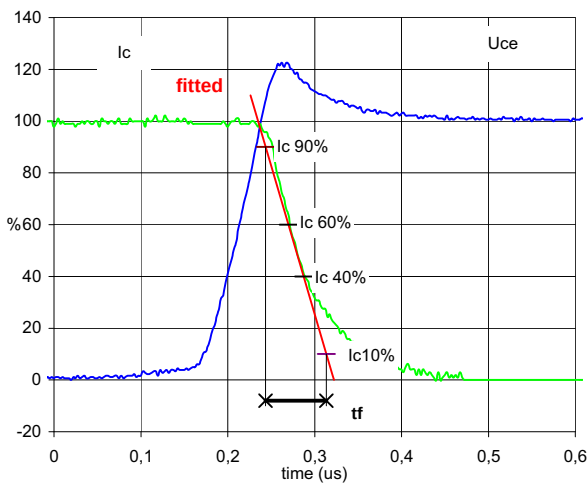
$U_{ge}(0\%) = -15\text{ V}$
 $U_{ge}(100\%) = 15\text{ V}$
 $U_{ce}(100\%) = 300\text{ V}$
 $I_{c}(100\%) = 100\text{ A}$
 $t_{doff} = 0,25\text{ us}$
 $t_{Eoff} = 0,48\text{ us}$

Figure 2. Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
(t_{Eon} = integrating time for E_{on})
Output inverter IGBT



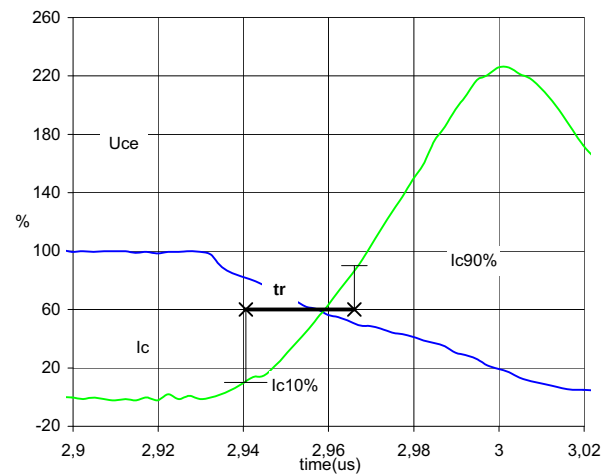
$U_{ge}(0\%) = -15\text{ V}$
 $U_{ge}(100\%) = 15\text{ V}$
 $U_{ce}(100\%) = 300\text{ V}$
 $I_{c}(100\%) = 99,7\text{ A}$
 $t_{don} = 0,07\text{ us}$
 $t_{Eon} = 0,31\text{ us}$

Figure 3. Turn-off Switching Waveforms & definition of t_f
Output inverter IGBT



$U_{ce}(100\%) = 300\text{ V}$
 $I_{c}(100\%) = 100\text{ A}$
 $t_f = 0,071\text{ us}$

Figure 4. Turn-on Switching Waveforms & definition of t_r
Output inverter IGBT



$U_{ce}(100\%) = 300\text{ V}$
 $I_{c}(100\%) = 99,7\text{ A}$
 $t_r = 0,026\text{ us}$

Switching definitions

Figure 5. Turn-off Switching Waveforms & definition of t_{Eoff}
Output inverter IGBT

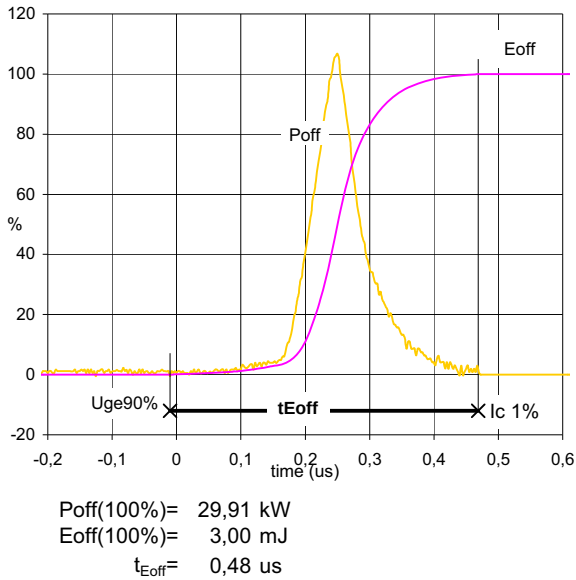


Figure 6. Turn-on Switching Waveforms & definition of t_{Eon}
Output inverter IGBT

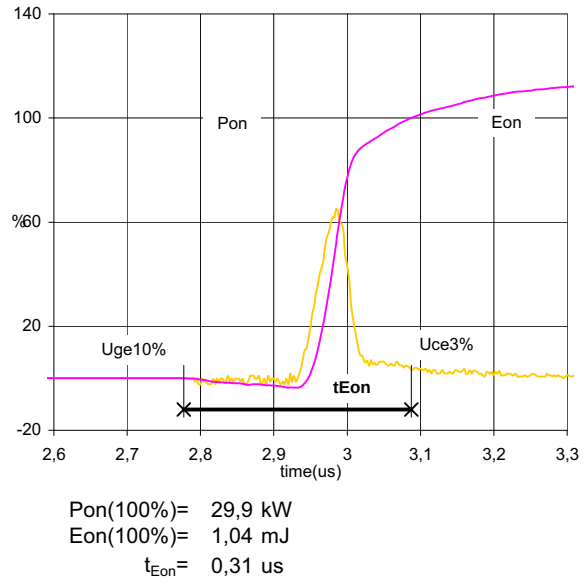


Figure 7. Gate voltage vs Gate charge
Output inverter IGBT

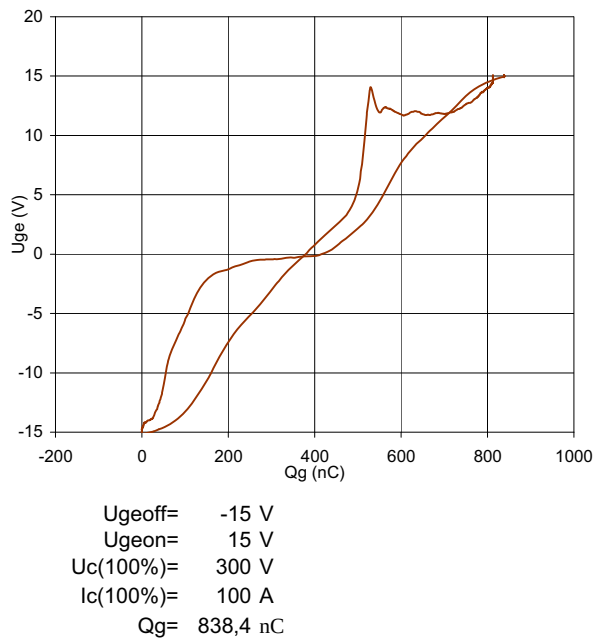
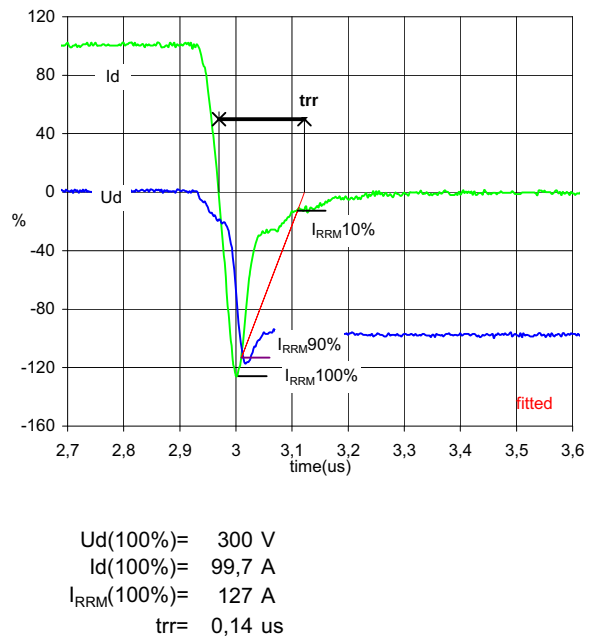


Figure 8. Turn-off Switching Waveforms & definition of t_{rr}
Output inverter FRED



Switching definitions

Figure 9. Turn-on Switching Waveforms & definition of t_{Qrr}
(t_{Qrr} = integrating time for Q_{rr})
Output inverter FRED

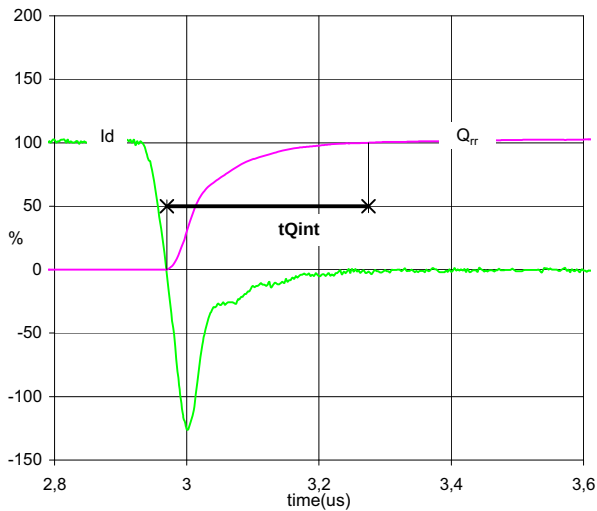
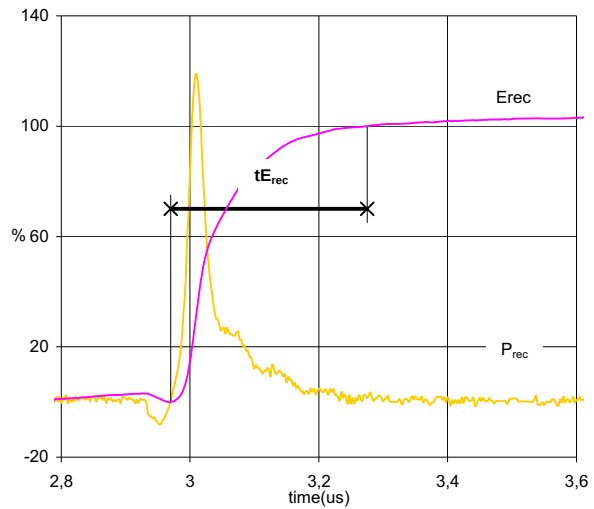


Figure 10. Turn-on Switching Waveforms & definition of t_{Erec}
(t_{Erec} = integrating time for E_{rec})
Output inverter FRED



Output inverter

Figure 1. Typical output characteristics
Output inverter IGBT
 $I_C = f(V_{CE})$

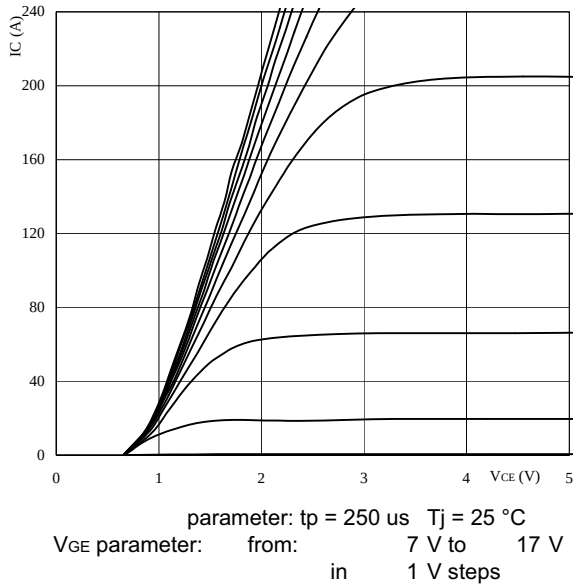


Figure 2. Typical output characteristics
Output inverter IGBT
 $I_C = f(V_{CE})$

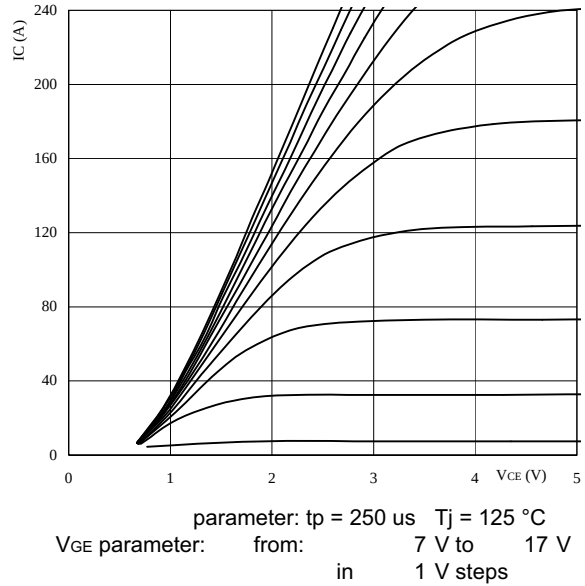


Figure 3. Typical transfer characteristics
Output inverter IGBT
 $I_C = f(V_{GE})$

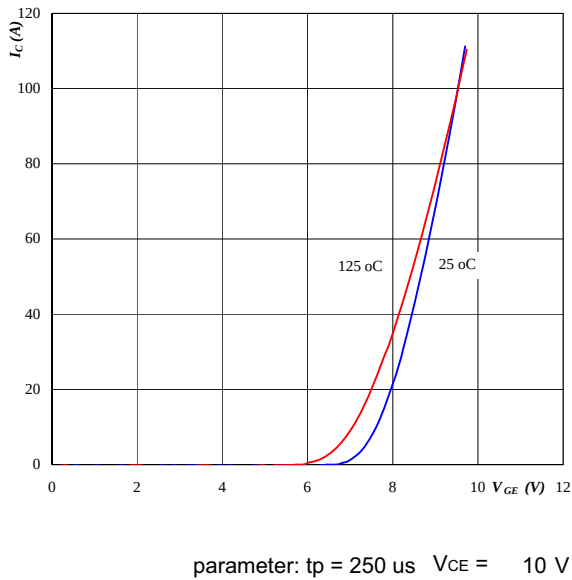
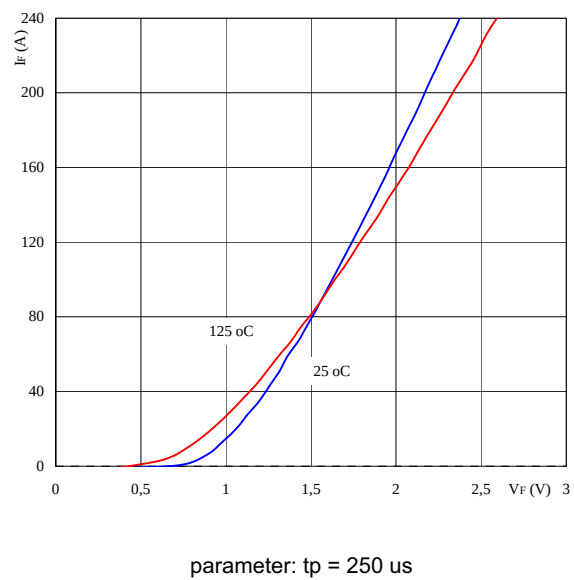
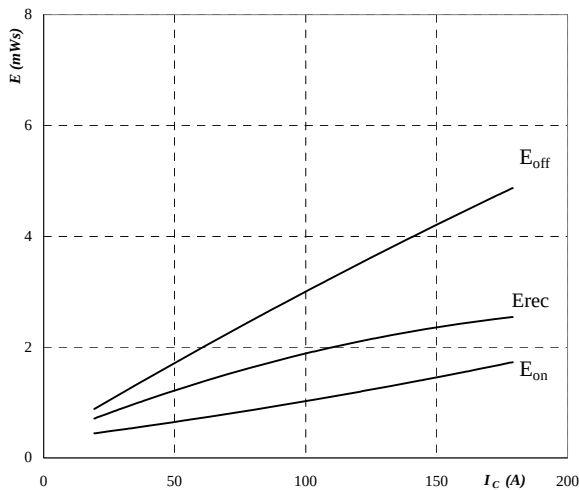


Figure 4. Typical diode forward current as a function of forward voltage
Output inverter FRED $I_F = f(V_F)$



Output inverter

Figure 5. Typical switching energy losses as a function of collector current
Output inverter IGBT
 $E = f(I_c)$



inductive load, $T_j = 125^\circ\text{C}$

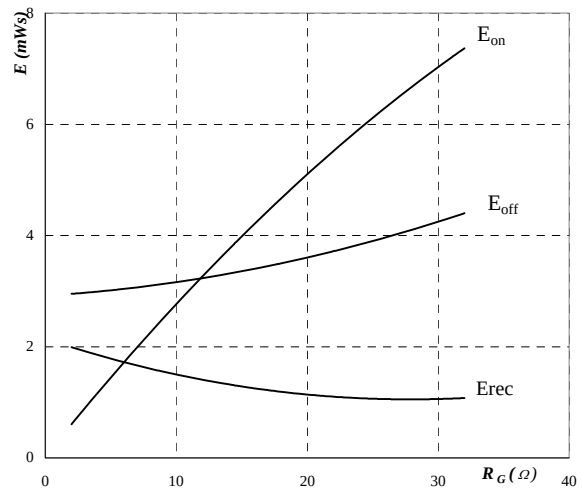
$V_{CE} = 300\text{ V}$

$V_{GE} = \pm 15\text{ V}$

$R_{gon} = 4\ \Omega$

$R_{goff} = 4\ \Omega$

Figure 6. Typical switching energy losses as a function of gate resistor
Output inverter IGBT
 $E = f(R_G)$



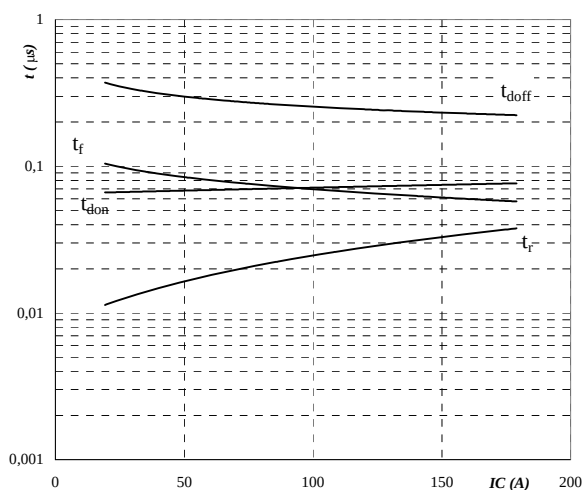
inductive load, $T_j = 125^\circ\text{C}$

$V_{CE} = 300\text{ V}$

$V_{GE} = \pm 15\text{ V}$

$I_c = 100\text{ A}$

Figure 7. Typical switching times as a function of collector current
Output inverter IGBT
 $t = f(I_c)$



inductive load, $T_j = 125^\circ\text{C}$

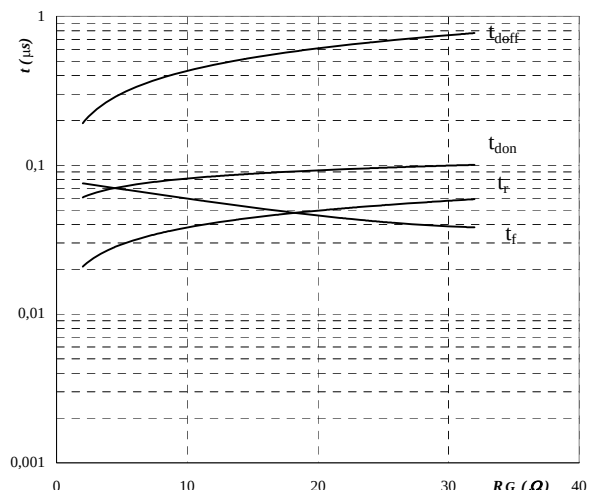
$V_{CE} = 300\text{ V}$

$V_{GE} = \pm 15\text{ V}$

$R_{gon} = 4\ \Omega$

$R_{goff} = 4\ \Omega$

Figure 8. Typical switching times as a function of gate resistor
Output inverter IGBT
 $t = f(R_G)$



inductive load, $T_j = 125^\circ\text{C}$

$V_{CE} = 300\text{ V}$

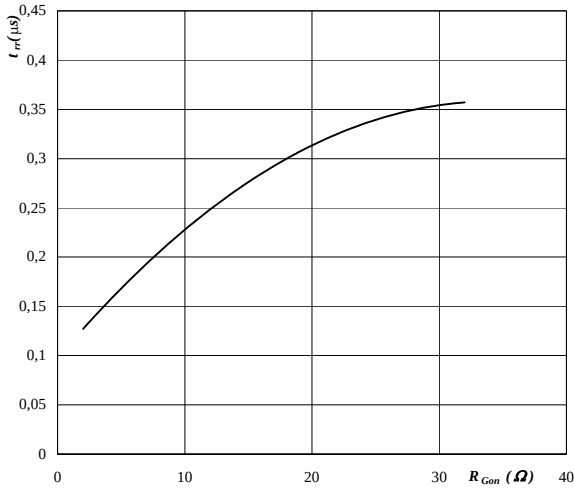
$V_{GE} = \pm 15\text{ V}$

$I_c = 100\text{ A}$

Output inverter

Figure 9. Typical reverse recovery time as a function of IGBT turn on gate resistor

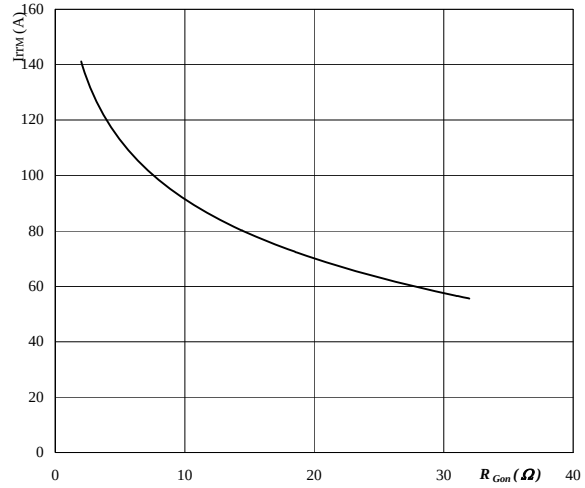
Output inverter FRED diode
 $t_{rr} = f(R_{gon})$



$T_j = 125^\circ C$
 $V_R = 300 V$
 $I_F = 100 A$
 $V_{GE} = \pm 15 V$

Figure 10. Typical reverse recovery current as a function of IGBT turn on gate resistor

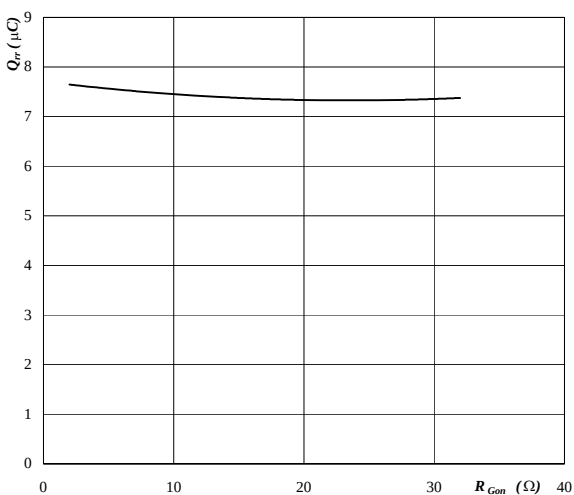
Output inverter FRED diode
 $I_{RRM} = f(R_{gon})$



$T_j = 125^\circ C$
 $V_R = 300 V$
 $I_F = 100 A$
 $V_{GE} = \pm 15 V$

Figure 11. Typical reverse recovery charge as a function of IGBT turn on gate resistor

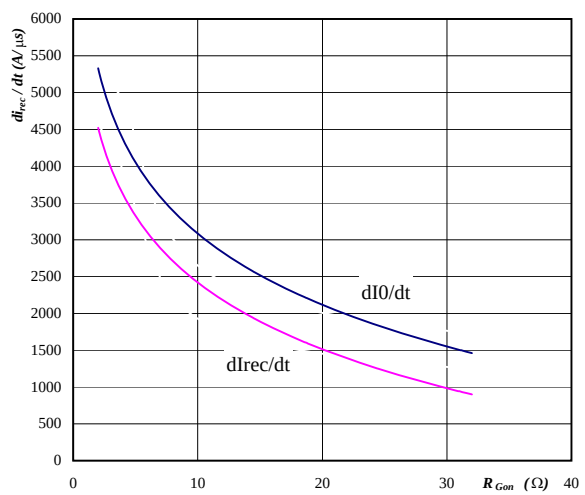
Output inverter FRED diode
 $Q_{rr} = f(R_{gon})$



$T_j = 125^\circ C$
 $V_R = 300 V$
 $I_F = 100 A$
 $V_{GE} = \pm 15 V$

Figure 12. Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

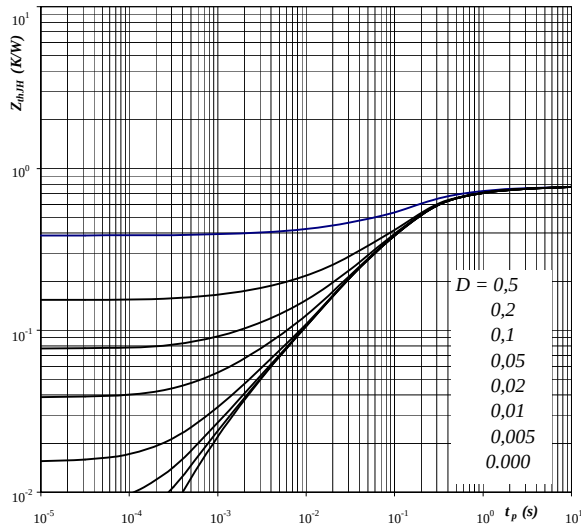
Output inverter FRED diode
 $dI_0/dt, dI_{rec}/dt = f(R_{gon})$



$T_j = 125^\circ C$
 $V_R = 300 V$
 $I_F = 100 A$
 $V_{GE} = \pm 15 V$

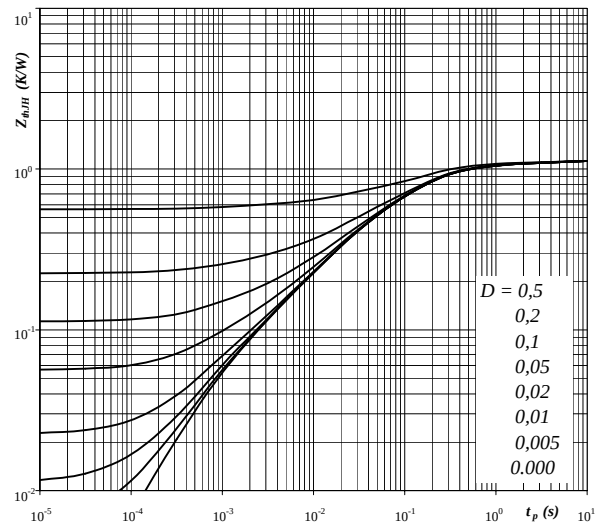
Output inverter

Figure 13. IGBT transient thermal impedance as a function of pulse width
 $Z_{thJH} = f(t_p)$


Parameter: $D = t_p / T$
 $R_{thJH} = 0,77 \text{ K/W}$
IGBT thermal model values

R (C/W)	Tau (s)
0,06	3,2E+00
0,16	5,0E-01
0,43	1,3E-01
0,10	1,5E-02
0,02	1,4E-03

Figure 14. FRED transient thermal impedance as a function of pulse width
 $Z_{thJH} = f(t_p)$


Parameter: $D = t_p / T$
 $R_{thJH} = 1,12 \text{ K/W}$
FRED thermal model values

R (C/W)	Tau (s)
0,08	3,2E+00
0,23	3,8E-01
0,56	9,7E-02
0,21	1,3E-02
0,05	1,0E-03

Output inverter

Figure 15. Power dissipation as a function of heatsink temperature

Output inverter IGBT
 $P_{tot} = f(T_h)$

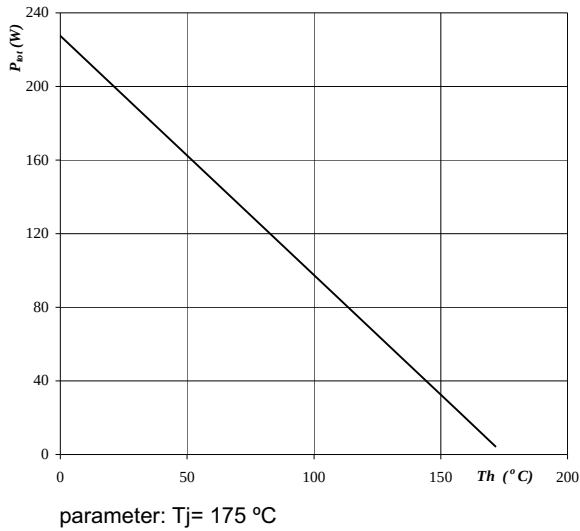


Figure 16. Collector current as a function of heatsink temperature

Output inverter IGBT
 $I_c = f(T_h)$

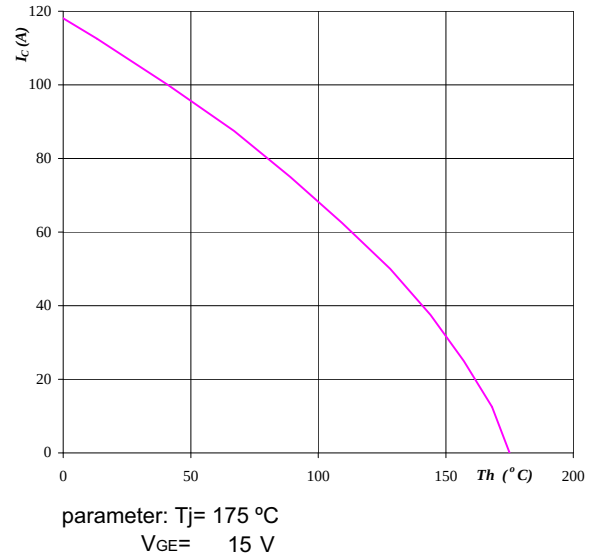


Figure 17. Power dissipation as a function of heatsink temperature

Output inverter FRED
 $P_{tot} = f(T_h)$

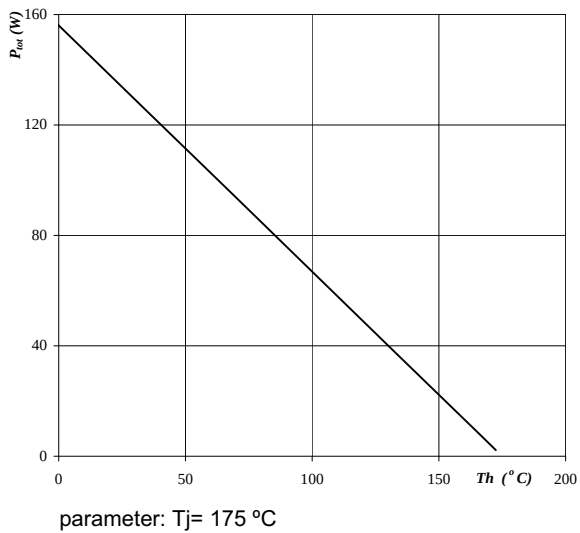


Figure 18. Forward current as a function of heatsink temperature

Output inverter FRED
 $I_F = f(T_h)$

